Notice of References Cited

Application/Control No.	Applicant(s)	/Patent Under
10/086,025	Reexaminat ANDERSON	N ET AL.
Examiner	Art Unit	
Arlen Soderquist	1743	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,777,214	07-1998	Thompson et al.	73/61.59
	В	US-5,983,734	11-1999	Mathur et al.	73/864.24
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
		US-			
	J	US-			
	K	US-			
	L	US-			
11	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2,294,761	05-1996	GB	Dureault et al.	
	0	99/39198	08-1999	wo	Kingston	
	Р	131310	05-2000	JP	Tamaoki et al.	
	Q					
	R					•
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Marchante-Gayon, J. M. et al, Special Publication - Royal Society of Chemistry 1997, 202, 85-94.
	٧	Wiederin, D. R. et al, Analytical Chemistyr 1991, 63, 1626-1631.
	w	Seubert, A. Fresenius J. Anal. Chem. 1999, 364, 404-409.
	x	Dahmen, J. et al, Fresenius J. Anal. Chem. 1997, 359, 410-413.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 10/086,025 Examiner Arlen Soderquist Applicant(s)/Patent Under Reexamination ANDERSON ET AL. Art Unit Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	l	US-			
	J	US-			
	К	US-			
	L	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0				*	
	Р		·		- 7 70.0	
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Beauchemin, D. et al, Analytical Chemistry 1997, 69, 3183-3187.
	٧	Bartels, H. et al, GIT Fachz. Lab. 1977, 21, 1276-1278 and 1280-1282
	W	Slobodnik J. et al, Journal of Chromatography A 1996, 730, 353-371.
	X	Huang, CC. et al, Analytical Chemistry 1997, 69, 3930-3939.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 10/086,025 Examiner Art Unit Page 3 of 3

U.S. PATENT DOCUMENTS

		Degrament Number	Dete	 	
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
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	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Multala, R. et al, Kemia-Kemi 1977, 4, 627-631.
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.